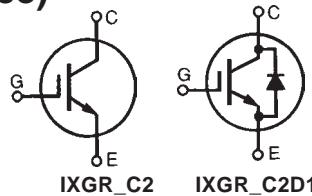


**HiPerFAST™ IGBT
ISOPLUS247™
Lightspeed 2™ Series
(Electrically Isolated Back Surface)**

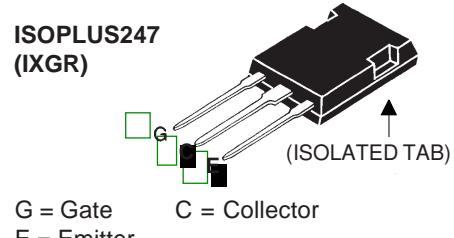
Preliminary Data Sheet

**IXGR 60N60C2
IXGR 60N60C2D1**

V_{CES}	= 600	V
I_{C25}	= 75	A
$V_{CE(sat)}$	= 2.7	V
$t_{fi(ty)}$	= 35	ns



Symbol	Test Conditions	Maximum Ratings		
V_{CES}	$T_J = 25^\circ\text{C}$ to 150°C	600	V	
V_{CGR}	$T_J = 25^\circ\text{C}$ to 150°C ; $R_{GE} = 1 \text{ M}\Omega$	600	V	
V_{GES}	Continuous	± 20	V	
V_{GEM}	Transient	± 30	V	
I_{C25}	$T_c = 25^\circ\text{C}$ (limited by leads)	75	A	
I_{C110}	$T_c = 110^\circ\text{C}$	48	A	
I_{F110}	$T_c = 110^\circ\text{C}$ (IXGR60N60C2D1)	39	A	
I_{CM}	$T_c = 25^\circ\text{C}, 1 \text{ ms}$	300	A	
SSOA	$V_{GE} = 15 \text{ V}, T_{VJ} = 125^\circ\text{C}, R_G = 10 \Omega$	$I_{CM} = 100$	A	
(RBSOA)	Clamped inductive load @ $V_{CE} \leq 600 \text{ V}$			
P_c	$T_c = 25^\circ\text{C}$	250	W	
T_J		-55 ... +150	$^\circ\text{C}$	
T_{JM}		150	$^\circ\text{C}$	
T_{stg}		-55 ... +150	$^\circ\text{C}$	
V_{ISOL}	50/60 Hz RMS, $t = 1\text{m}$	2500	V	
Weight		5	g	
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	$^\circ\text{C}$	



Features

- DCB Isolated mounting tab
- Meets TO-247AD package Outline
- High current handling capability
- Latest generation HDMOS™ process
- MOS Gate turn-on
 - drive simplicity

Applications

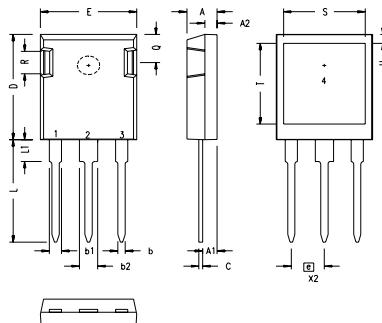
- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies
- AC motor speed control
- DC servo and robot drives
- DC choppers

Advantages

- Easy assembly
- High power density
- Very fast switching speeds for high frequency applications

Symbol	Test Conditions	Characteristic Values		
		($T_J = 25^\circ\text{C}$, unless otherwise specified)		
		Min.	Typ.	Max.
BV_{CES}	$I_c = 1 \text{ mA}, V_{GE} = 0 \text{ V}$	600		V
$V_{GE(th)}$	$I_c = 250 \mu\text{A}, V_{CE} = V_{GE}$	3.0		V
I_{CES}	$V_{CE} = V_{CES}$ $V_{GE} = 0 \text{ V}$	GR60N60C2 GR60N60C2D1		μA
I_{GES}	$V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$		± 100	nA
$V_{CE(sat)}$	$I_c = 50 \text{ A}, V_{GE} = 15 \text{ V}$ Note 1	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	2.3 2.0	V

Symbol	Test Conditions	Characteristic Values			
		(T _J = 25°C, unless otherwise specified)	Min.	Typ.	Max.
g_{fs}	I _C = 50 A; V _{CE} = 10 V, Note 1	40	55	S	
C_{ies}		3900		pF	
C_{oes}	V _{CE} = 25 V, V _{GE} = 0 V, f = 1 MHz	60N60C2	280	pF	
		60N60C2D1	320	pF	
C_{res}		97		pF	
Q_g		140		nC	
Q_{ge}	I _C = 50 A, V _{GE} = 15 V, V _{CE} = 0.5 V _{CES}	28		nC	
Q_{gc}		35		nC	
t_{d(on)}	Inductive load, T_j = 25°C	18		ns	
t_{ri}		25		ns	
t_{d(off)}		95	150	ns	
t_{fi}		35		ns	
E_{off}		0.49	0.8	mJ	
t_{d(on)}	Inductive load, T_j = 125°C	18		ns	
t_{ri}		25		ns	
E_{on}		1.6		mJ	
t_{d(off)}		130		ns	
t_{fi}		80		ns	
E_{off}		0.92		mJ	
R _{thJ-DCB}	(Note 2)	0.25		K/W	
R _{thJC}	(Note 3)		0.50	K/W	
R _{thCS}		0.15		K/W	

ISOPLUS 247 Outline


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.045	.055	1.14	1.40
b1	.075	.084	1.91	2.13
b2	.115	.123	2.92	3.12
C	.024	.031	0.61	0.80
D	.819	.840	20.80	21.34
E	.620	.635	15.75	16.13
e	.215 BSC		5.45 BSC	
L	.780	.800	19.81	20.32
L1	.150	.170	3.81	4.32
Q	.220	.244	5.59	6.20
R	.170	.190	4.32	4.83
S	.520	.540	13.21	13.72
T	.620	.640	15.75	16.26
U	.065	.080	1.65	2.03

1 - GATE
 2 - DRAIN (COLLECTOR)
 3 - SOURCE (EMITTER)
 4 - NO CONNECTION

NOTE: This drawing will meet all dimensions requirement of JEDEC outline TO-247AD except screw hole.

Symbol	Test Conditions	Characteristic Values			
		(T _J = 25°C, unless otherwise specified)	min.	typ.	max.
V_F	I _F = 60 A, V _{GE} = 0 V, Note 1		2.0	V	
		T _J = 150°C	1.39		
I_{RM}	I _F = 60 A, V _{GE} = 0 V, -di _F /dt = 100 A/μs, T _J = 100°C V _R = 100 V		8.3	A	
t_{rr}	I _F = 1 A; -di/dt = 200 A/ms; V _R = 30 V	35		ns	
R_{thJC}			0.85	K/W	

Note 1: Pulse test, t ≤ 300 μs, duty cycle ≤ 2 %

2: R_{thJ-DCB} is the thermal resistance junction-to-internal side of DCB substrate

3: R_{thJC} is the thermal resistance junction-to-external side of DCB substrate

Fig. 1. Output Characteristics
@ 25 Deg. C

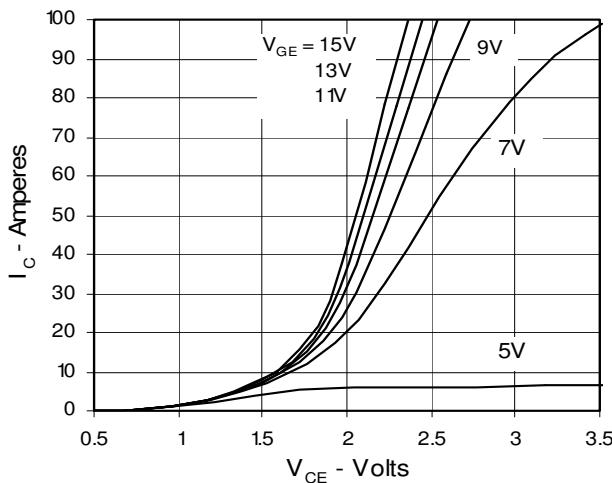


Fig. 2. Extended Output Characteristics
@ 25 deg. C

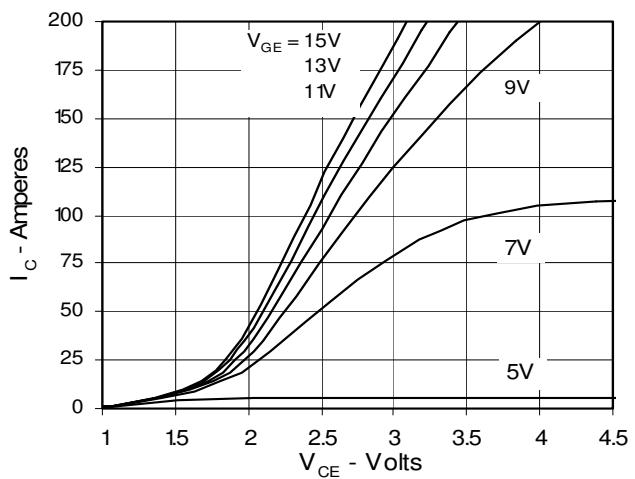


Fig. 3. Output Characteristics
@ 125 Deg. C

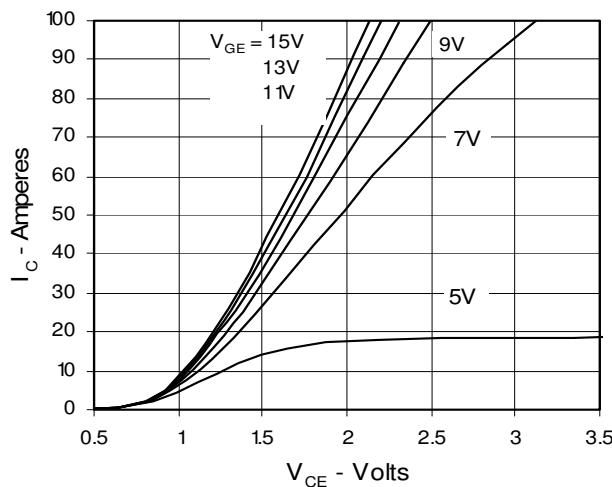


Fig. 4. Temperature Dependence of $V_{CE(sat)}$

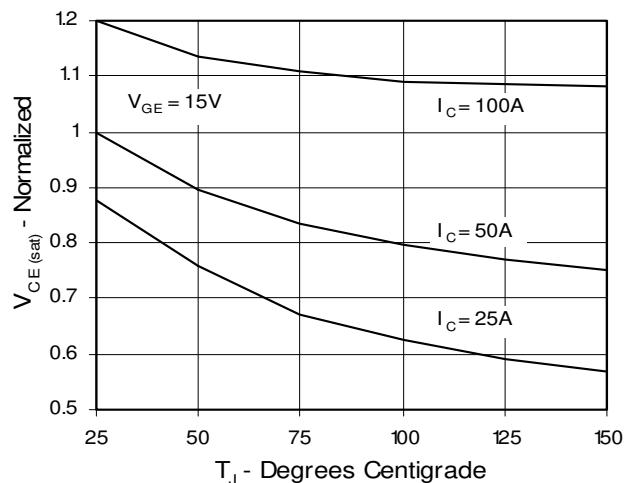


Fig. 5. Collector-to-Emitter Voltage
vs. Gate-to-Emitter voltage

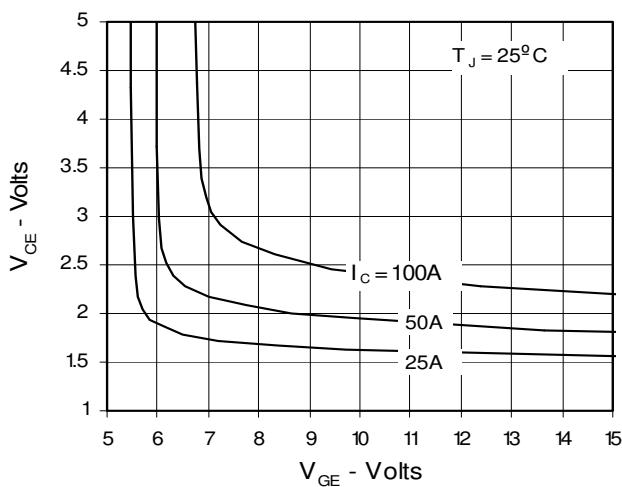


Fig. 6. Input Admittance

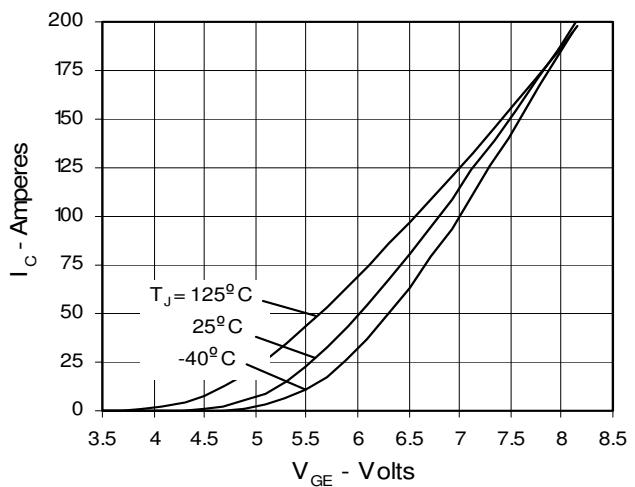


Fig. 7. Transconductance

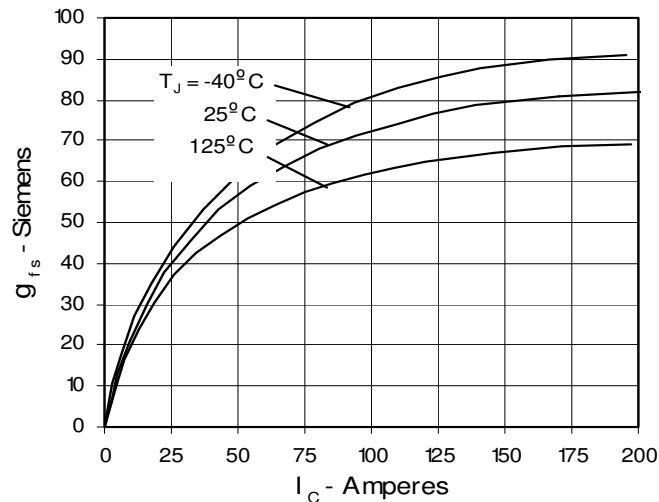


Fig. 8. Dependence of E_{off} on R_G

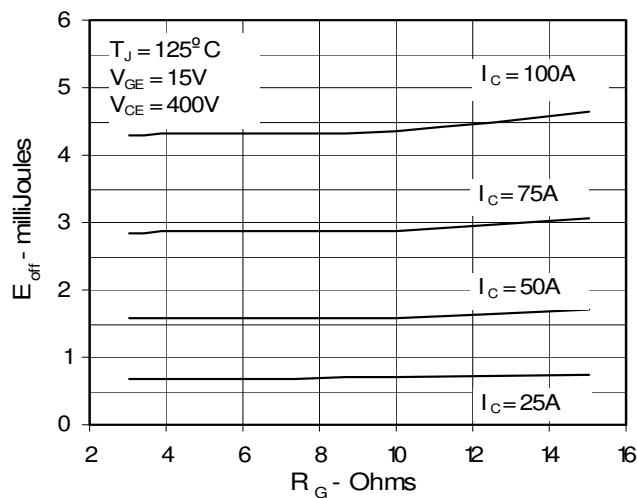


Fig. 9. Dependence of E_{off} on I_C

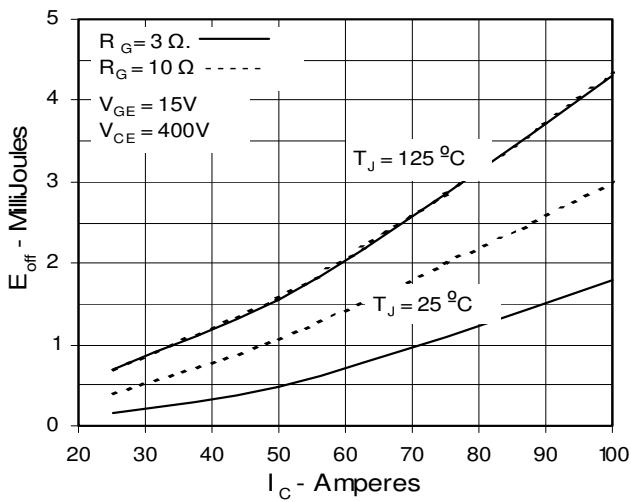


Fig. 10. Dependence of E_{off} on Temperature

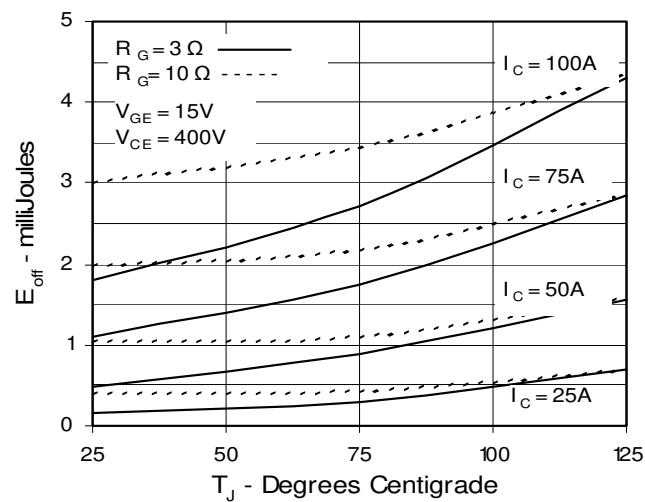


Fig. 11. Gate Charge

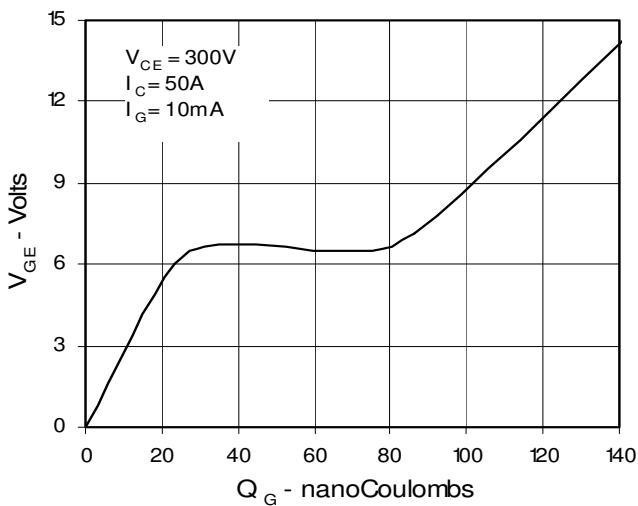


Fig. 12. Capacitance

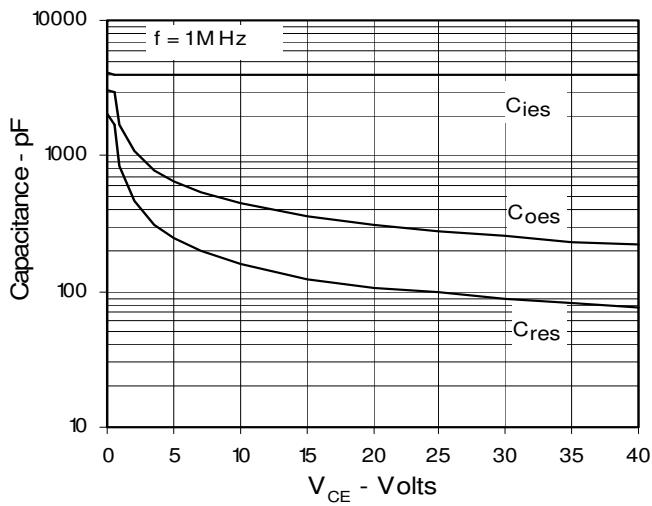
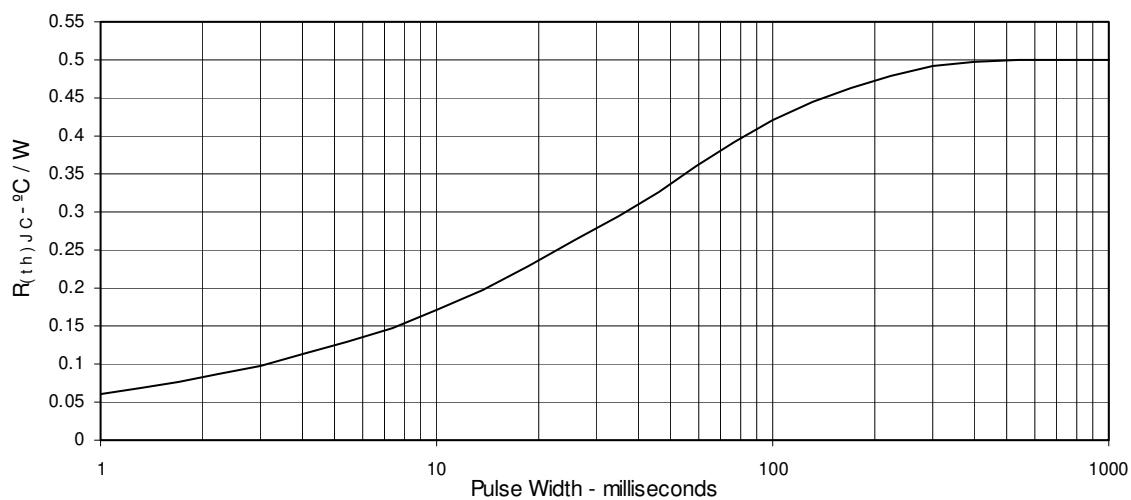


Fig. 13. Maximum Transient Thermal Resistance

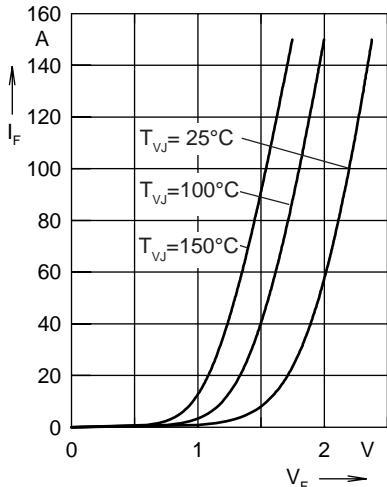


Fig. 14. Forward current I_F versus V_F

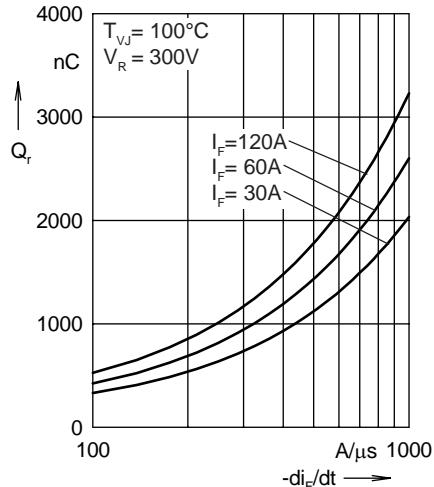


Fig. 15. Reverse recovery charge Q_r versus $-di_F/dt$

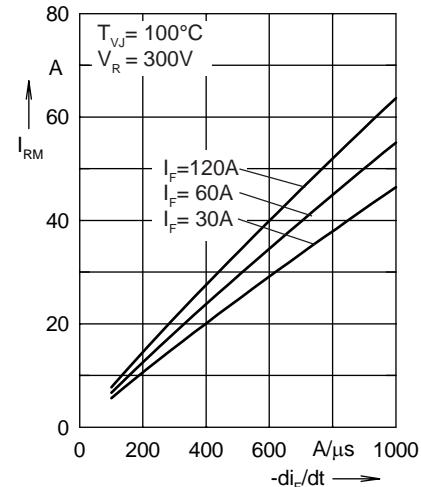


Fig. 16. Peak reverse current I_{RM} versus $-di_F/dt$

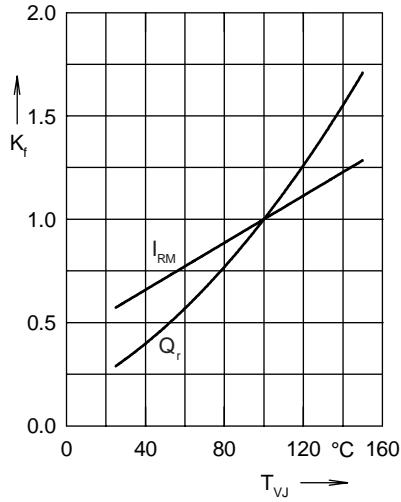


Fig. 17. Dynamic parameters Q_r , I_{RM} versus T_{VJ}

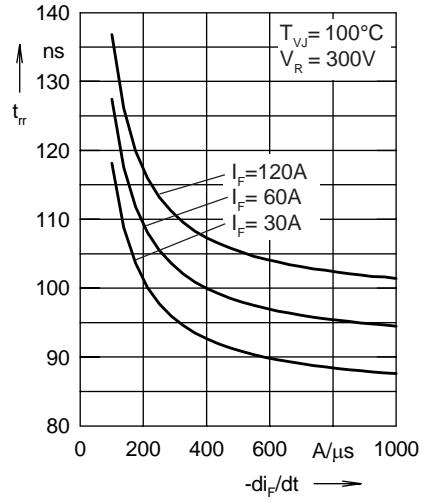


Fig. 18. Recovery time t_{rr} versus $-di_F/dt$

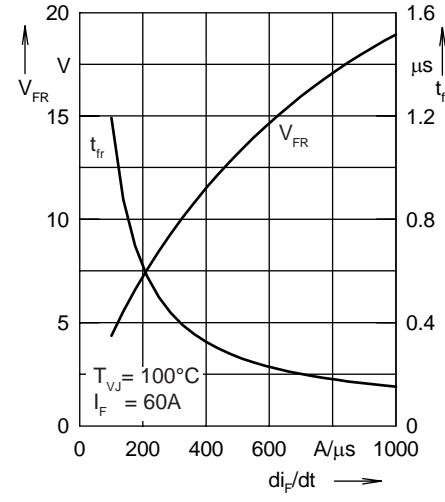


Fig. 19. Peak forward voltage V_{FR} and t_{fr} versus di_F/dt

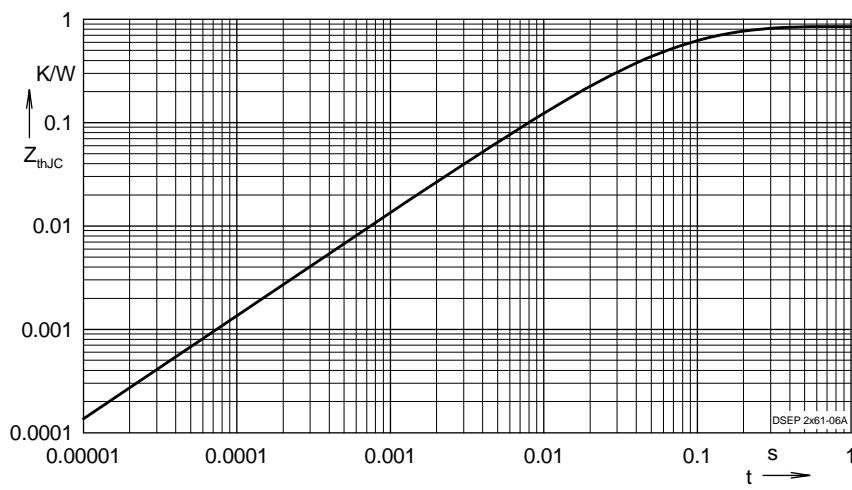


Fig. 20. Transient thermal resistance junction to case

Constants for Z_{thJC} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.3073	0.0055
2	0.3533	0.0092
3	0.0887	0.0007
4	0.1008	0.0399